



ALTERNATIVE TO PTO/SB/08A/B (09/06)

Substitute for form 1449/PTO			Complete if Known		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Application Number	10/713,753	
			Filing Date	November 13, 2003	
			First Named Inventor	Bruce W. MCGAUGHY	
			Art Unit	2123	
			Examiner Name	A. Pierre-Louise	
Sheet	1	of	1	Attorney Docket Number	188122002000

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
APL	1.	US-2003/0237067-A1	12-25-2003	Mielke et al.	
APL	2.	US-2004/0078767-A1	04-22-2004	Burks et al.	
APL	3.	US-4,942,536-A	07-17-1990	Watanabe et al.	
APL	4.	US-5,910,898-A	06-08-1999	Johannsen	
APL	5.	US-6,026,226-A	02-15-2000	Heile et al.	
APL	6.	US-6,035,107-A	03-07-2000	Kuehlmann et al.	
APL	7.	US-6,301,687-B1	10-09-2001	Jain et al.	
APL	8.	US-6,339,836-B1	01-15-2002	Eisenhofer et al.	
APL	9.	US-6,374,205-B1	04-16-2002	Kuribayashi et al.	
APL	10.	US-6,449,761-B1	09-10-2002	Greidinger et al.	
APL	11.	US-6,571,377-B2	05-27-2003	Narita	
APL	12.	US-6,865,525-B1	03-08-2005	Zhong	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁵
		Country Code ² -Number ³ -Kind Code ⁴ (if known)	MM-DD-YYYY			

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	13.	Chakrabarti, D.R. et al. (November 23-24, 1995). "An Improved Hierarchical Test Generation Technique for Combinational Circuits with Repetitive Sub-circuits," <i>Proceedings of the Fourth Asian Test Symposium 1995</i> , 1:237-243.	
	14.	Jones et al. (February 1994). "A Cache-Based Method for Acceleration Switch-Level Simulation," <i>IEEE Transactions on Computer-Aided Design of Integrated Circuits and Systems</i> 13(2).	
	15.	Stanford.edu. "Radix 2 FFT Complexity is N Log N," <i>In Mathematics of the Discrete Fourier Transform (DFT), with Music and Audio Application</i> . Smith, III, J.O. (2003). W3K Publishing: Stanford, located at < http://ccma.stanford.edu/~jos/mdft/Radix_2_FFT_Complexity.html >, 1 page.	
	16.	Wong, Y. (1985). "Hierarchical Circuit Verification," <i>IEEE 22nd Design Automation Conference</i> .	

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Examiner Signature		Date Considered	5/11/07
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